

STP8NM50 STP8NM50FP

N-channel 550V @ Tjmax - 0.7Ω - 8A - TO-220 - TO-220FP MDmesh[™] Power MOSFET

General features

Туре	V _{DSS} (@Tjmax) R _{DS(on)}		I _D
STP8NM50	550V	<0.8Ω	8A
STP8NM50FP	550V	<0.8Ω	8A ⁽¹⁾

1. Limited only by maximum temperature allowed

- 100% avalanche tested
- High dv/dt and avalanche capabilities
- Low gate input resistance
- Low input capacitance and gate charge

Description

The MDmesh[™] is a new revolutionary Power MOSFET technology that associates the multiple drain process with the company's PowerMESH™ horizontal layout. The resulting product has an outstanding low on-resistance, impressively high dv/dt and excellent avalanche characteristics. The adoption of the company's proprietary strip technique yields overall dynamic performance that is significantly better than that of similar competition's products.

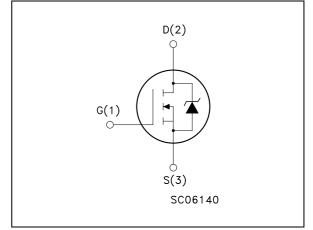
Applications

Switching application

Order codes

۲O-220	TO-220FP

Internal schematic diagram



Part number	Marking	Package	Packaging
STP8NM50	P8NM50	TO-220	Tube
STP8NM50FP	P8NM50FP	TO-220FP	Tube

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1 Electrical ratings

Symbol	Parameter	Valu	Unit		
Symbol	Farameter	TO-220	TO-220FP	Unit	
V _{GS}	Gate-source voltage	± 3	0	V	
۱ _D	Drain current (continuous) at $T_C = 25^{\circ}C$	8	8 (1)	Α	
I _D	Drain current (continuous) at T _C = 100°C	ontinuous) at $T_C = 100^{\circ}C$ 5 5 (1)		А	
I _{DM} ⁽²⁾	Drain current (pulsed)	32 32 ⁽¹⁾		Α	
P _{TOT}	Total dissipation at $T_C = 25^{\circ}C$	100	25	W	
	Derating factor	0.8	3	W/°C	
dv/dt ⁽³⁾	Peak diode recovery voltage slope	15		V/ns	
V _{ISO}	Insulation withstand voltage (RMS) from all three leads to external heat sink (t=1s;TC=25°C)		2500	V	
T _j T _{stg}	Operating junction temperature Storage temperature	-65 to	150	°C	

Table 1. Absolute maximum ratings

1. Limited only by maximum temperature allowed

2. Pulse width limited by safe operating area

3. $I_{SD} \leq 8$ A, di/dt ≤ 200 A/µs, $V_{DD} \leq V_{(BR)DSS}$, $T_j \leq T_{JMAX.}$

Table 2. Thermal data

Symbol	Parameter	Parameter TO-220 TO-220FP		Unit
Rthj-case	Thermal resistance junction-case max	1.25	5	°C/W
Rthj-amb	Thermal resistance junction-amb max	62.5	i	°C/W
Τ _Ι	Maximum lead temperature for soldering purpose	300		°C

Table 3. Avalanche characteristics

Symbol	Parameter	Max value	Unit	
I _{AR}	Avalanche current, repetitive or not-repetitive (pulse width limited by Tj max)	2.5	А	
E _{AS}	Single pulse avalanche energy (starting Tj=25°C, I _D =I _{AR} , V _{DD} = 50V)	200	mJ	



2 Electrical characteristics

(T_{CASE}=25°C unless otherwise specified)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	Ι _D = 250μΑ, V _{GS} = 0	500			V
I _{DSS}	Zero gate voltage drain current (V _{GS} = 0)	V _{DS} = Max rating, V _{DS} = Max rating @125°C			1 10	μΑ μΑ
I _{GSS}	Gate body leakage current (V _{DS} = 0)	V _{GS} = ±30 V			±100	nA
V _{GS(th)}	Gate threshold voltage	V_{DS} = V_{GS} , I_D = 250 μ A	3	4	5	V
R _{DS(on)}	Static drain-source on resistance	V _{GS} = 10 V, I _D = 2.5A		0.7	0.8	Ω

Table 4. On/off states

Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
$g_{fs}^{(1)}$	Forward transconductance	$V_{DS} > I_{D(on)} \times R_{DS(on)max,}$ $I_{D}= 2.5 A$		2.4		S
C _{iss} C _{oss} C _{rss}	Input capacitance Output capacitance Reverse transfer capacitance	V _{DS} =25V, f=1 MHz, V _{GS} =0		415 88 12		pF pF pF
C _{oss eq.} ⁽²⁾	Equivalent ouput capacitance	V_{GS} =0, V_{DS} =0V to 400V		50		pF
Q _g Q _{gs} Q _{gd}	Total gate charge Gate-source charge Gate-drain charge	V_{DD} =400V, I_D = 5A V_{GS} =10V (see Figure 16)		13 4 6		nC nC nC
R _G	Gate input resistance	f=1MHz Gate DC Bias = 0 Test signal level = 20mV Open drain		3		Ω

1. Pulsed: pulse duration=300µs, duty cycle 1.5%

2. $C_{oss\,eq.}$ is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}

	e mitering timee					
Symbol	Parameter	Test conditions	Min	Тур	Max	Unit
t _{d(on)} t _r	Turn-on delay time Rise time	V_{DD} =250 V, I _D =2.5A, R _G =4.7 Ω , V _{GS} =10V (see Figure 15)		16 8		ns ns
t _{r(Voff)} t _f t _c	Off-voltage rise time Fall time Cross-over time	V_{DD} =400 V, I _D =5A, R _G =4.7 Ω , V _{GS} =10V (see Figure 15)		14 6 13		ns ns ns

Table 6. Switching times

Table 7.Source drain diode

Symbol	Parameter	Test conditions	Min	Тур	Max	Unit
I _{SD} I _{SDM}	Source-drain current Source-drain current (pulsed)				8 32	A A
V _{SD}	Forward on voltage	I _{SD} =10A, V _{GS} =0			1.5	V
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	I _{SD} =5A, di/dt = 100A/μs, V _{DD} =100 V, Tj=25°C (<i>see Figure 20</i>)		185 1.1 11.5		ns μC Α
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	I _{SD} =5A, di/dt = 100A/µs, V _{DD} =100 V, Tj=150°C <i>(see Figure 20)</i>		270 1.6 12		ns μC Α



2.1 Electrical characteristics (curves)



Figure 2. Thermal impedance for TO-220

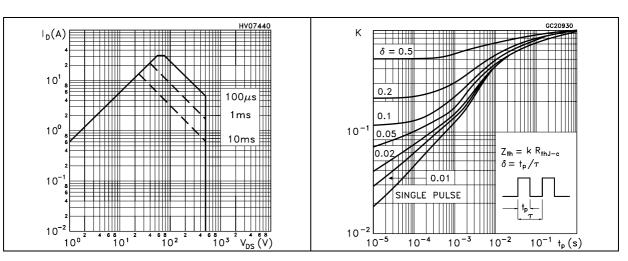
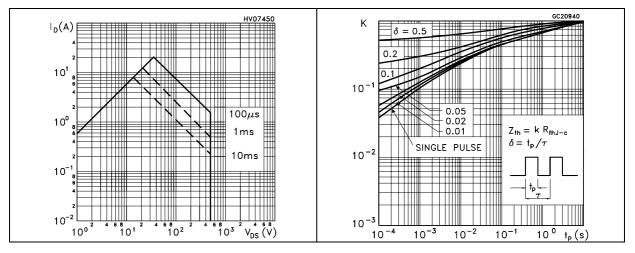


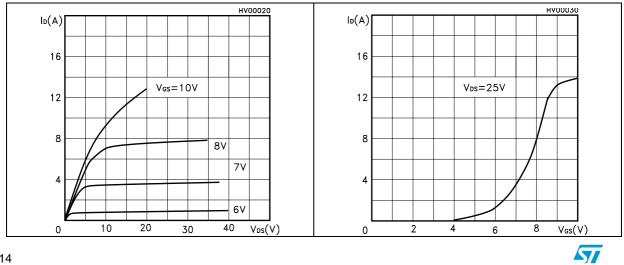
Figure 3. Safe operating area for TO-220FP

Figure 4. Safe operating area for TO-220FP









Static drain-source on resistance

Figure 7. Transconductance

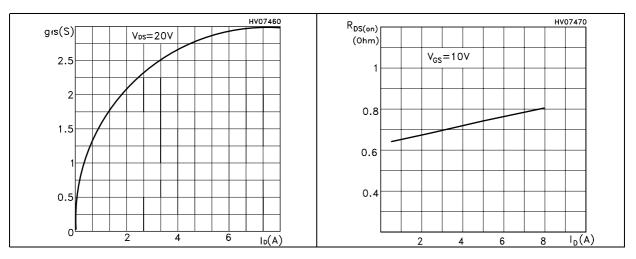


Figure 8.

Figure 9. Gate charge vs gate-source voltage Figure 10. Capacitance variations

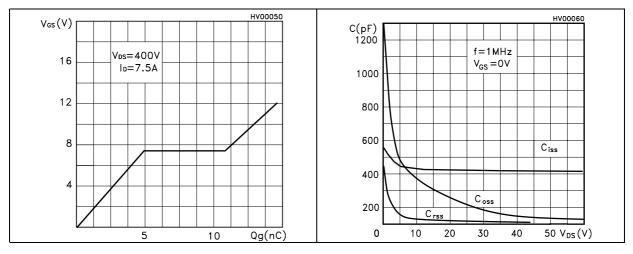
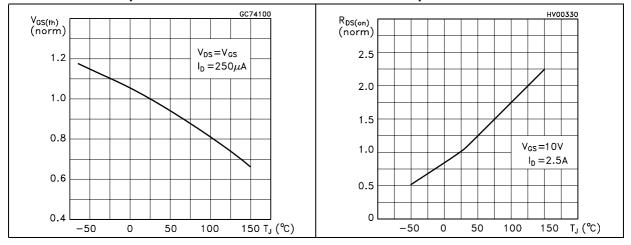


Figure 11. Normalized gate threshold voltage Figure 12. vs temperature

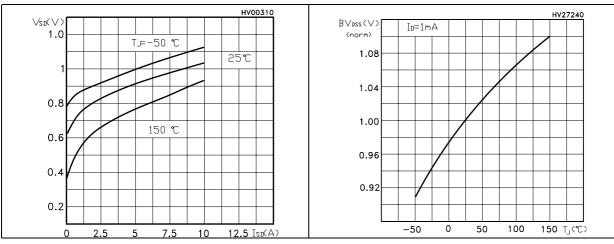
re 12. Normalized on resistance vs temperature



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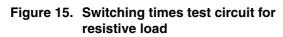


STP8NM50 - STP8NM50FP



diode forward Figure 14. Normali

3 Test circuit



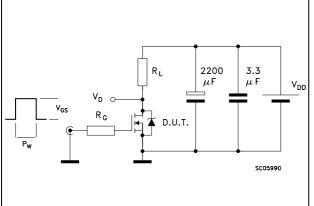
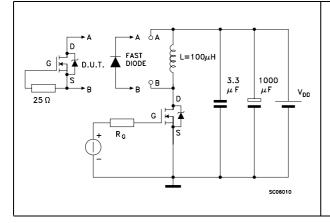


Figure 17. Test circuit for inductive load switching and diode recovery times





I_D

 V_{DD}

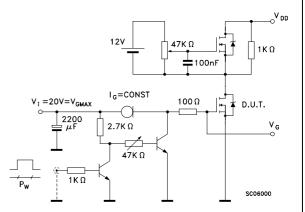


Figure 16. Gate charge test circuit

Figure 18. Unclamped Inductive load test circuit

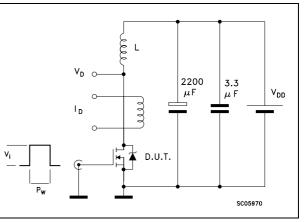
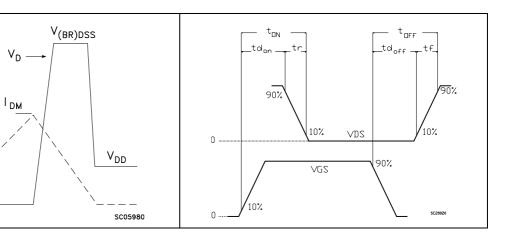


Figure 20. Switching time waveform



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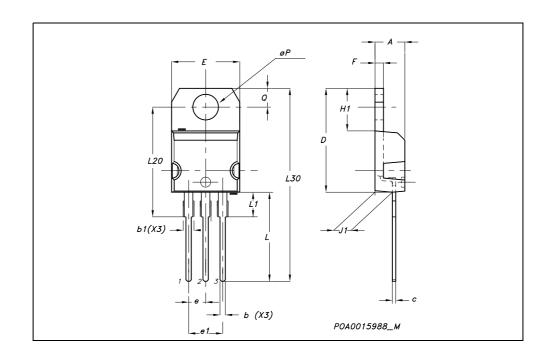
4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect . The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com



DIM.		mm.			inch	
DIM.	MIN.	ТҮР	MAX.	MIN.	TYP.	MAX.
А	4.40		4.60	0.173		0.181
b	0.61		0.88	0.024		0.034
b1	1.15		1.70	0.045		0.066
С	0.49		0.70	0.019		0.027
D	15.25		15.75	0.60		0.620
Е	10		10.40	0.393		0.409
е	2.40		2.70	0.094		0.106
e1	4.95		5.15	0.194		0.202
F	1.23		1.32	0.048		0.052
H1	6.20		6.60	0.244		0.256
J1	2.40		2.72	0.094		0.107
L	13		14	0.511		0.551
L1	3.50		3.93	0.137		0.154
L20		16.40			0.645	
L30		28.90			1.137	
øP	3.75		3.85	0.147		0.151
Q	2.65		2.95	0.104		0.116

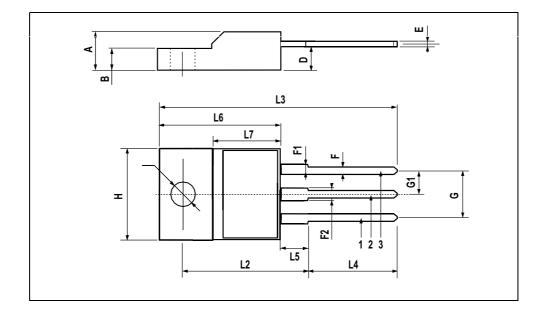
TO-220 MECHANICAL DATA



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DIM.	mm.			inch		
	MIN.	ТҮР	MAX.	MIN.	TYP.	MAX.
А	4.4		4.6	0.173		0.181
В	2.5		2.7	0.098		0.106
D	2.5		2.75	0.098		0.108
Е	0.45		0.7	0.017		0.027
F	0.75		1	0.030		0.039
F1	1.15		1.7	0.045		0.067
F2	1.15		1.7	0.045		0.067
G	4.95		5.2	0.195		0.204
G1	2.4		2.7	0.094		0.106
Н	10		10.4	0.393		0.409
L2		16			0.630	
L3	28.6		30.6	1.126		1.204
L4	9.8		10.6	.0385		0.417
L5	2.9		3.6	0.114		0.141
L6	15.9		16.4	0.626		0.645
L7	9		9.3	0.354		0.366
Ø	3		3.2	0.118		0.126





5 Revision history

Table 8.	Revision	history
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Date	Revision	Changes
09-Sep-2004	4	Title changed
11-Aug-2006	5	New template
22-Sep-2006	6	Some value change in Table 4: On/off states
18-Oct-2006	7	Updated Note 3 on page 3



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